

# Indications for a Line of Continuous Phase Transitions at Finite Temperatures Connected with the Apparent Metal-Insulator Transition in Two-Dimensional Disordered Systems

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In a recent experiment, Lai and coworkers studied the apparent metal-insulator transition (MIT) of a Si quantum well structure tuning the charge carrier concentration  $n$ .<sup>1</sup> They observed linear temperature dependences of the conductivity  $\sigma(T, n)$  around the Fermi temperature and found that the corresponding  $T \rightarrow 0$  extrapolation  $\sigma_0(n)$  exhibits a sharp bend just at the MIT. Here, reconsidering the data published by Lai *et al.*, it is shown that this sharp bend is related to a peculiarity of  $\sigma(T = \text{const.}, n)$  clearly detectable in the whole  $T$  range up to 4 K, the highest measuring temperature in that work.<sup>2</sup> Since this peculiarity seems not to be smoothed out with increasing  $T$  it may indicate a sharp continuous phase transition between the regions of apparent metallic and activated conduction to be present at finite temperature. Hints from the literature of such a behavior are discussed. Finally, a scaling analysis illuminates similarities to previous experiments and provides understanding of the shape of the peculiarity and of sharp peaks found in  $d\log_{10} \sigma / dn(n)$ .

<sup>1</sup>K. Lai, W. Pan, D.C. Tsui, S. Lyon, M. Mühlberger, and F. Schäffler, Phys. Rev. B **75**, 033314 (2007).

<sup>2</sup>A. Möbius, Phys. Rev. B **77**, 205317 (2008).